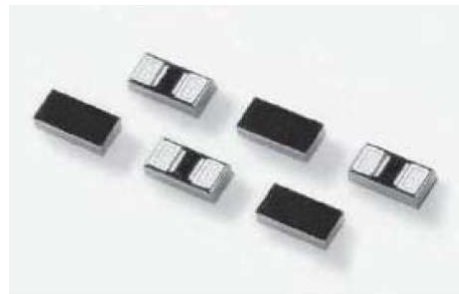


Electro-static Discharge (ESD)

0201

Description

The 0201 includes back-to-back Zener diodes fabricated in a proprietary silicon avalanche technology to provide protection for electronic equipment that may experience destructive electrostatic discharges(ESD). These robust diodes can safely absorb repetitive ESD strikes above the maximum level specified in the IEC61000-4-2 international standard (level 4, $\pm 8\text{kV}$ contact discharge) without performance degradation. The back-to-back configuration provides symmetrical ESD protection for data lines when AC signals are present.



Features

- ESD, IEC61000-4-2, $\pm 8\text{kV}$ contact, $\pm 15\text{kV}$ air
- EFT, IEC61000-4-4, 40A(5/50ns)
- Lightning, IEC61000-4-5, 10A($t_p=8/20\mu\text{s}$)
- Low capacitance of 5pF(@ $V_R=0\text{V}$)
- Low leakage current of 0.1 μA at 5V
- Space efficient 0201 footprint

Applications

- Mobile phones
- Smart phones
- Camcorders
- PDA
- Digital cameras
- MP3/PMP
- Portable navigation devices
- Portable medical
- Point of sale terminals

Absolute Maximum Ratings

Symbol	Parameter	Value	Units
I_{pp}	Peak current($t_p=8/20 \mu\text{s}$)	10.0	A
T_{op}	Operating Temperature	-40 to 85	$^{\circ}\text{C}$
T_{stor}	Storage Temperature	-65 to 150	$^{\circ}\text{C}$

CAUTION: Stresses above those listed in “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

Thermal Information:

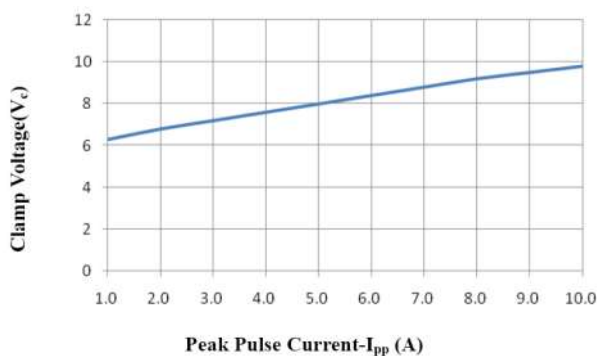
Parameter	Rating	Units
Storage Temperature Range	-65 to 150	°C
Maximum Junction Temperature	150	°C
Maximum Lead Temperature(Soldering 20-40s)	260	°C

Electrical Characteristics: (T_{op}=25°C)

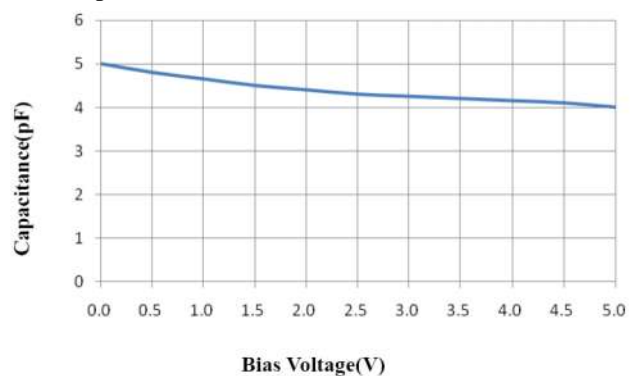
parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Reverse Standoff Voltage	V _{RWM}				5.0	V
Breakdown Voltage	V _{BR}	I _R =1mA	7.0	8.5	9.0	V
Leakage Current	I _{LEAK}	V _R =5V with 1 pin at GND		0.1	0.5	μA
Clamp Voltage ¹	V _C	I _{pp} =1A, t _p =8/20 μs, FWD		9.6		V
		I _{pp} =2A, t _p =8/20 μs, FWD		12.8		V
		I _{pp} =10A, t _p =8/20 μs, FWD		15.6		V
Dynamic Resistance	R _{DYN}	(V _{C2} -V _{C1})/(I _{pp2} -I _{pp1})		0.7		Ω
ESD Withstand Voltage ¹	V _{ESD}	IEC61000-4-2(Contact)	±8			kV
		IEC61000-4-2(Air)	±15			kV
Diode Capacitance ¹	C _D	Reverse Bias=0V		5.0		pF
		Reverse Bias=2.5V		4.0		pF

Note: 1Parameter is guaranteed by design and/or device characterization.

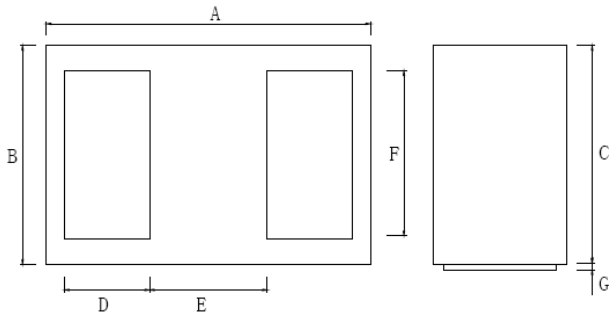
Clamping Voltage vs. I_{pp}



Capacitance vs. Reverse Bias

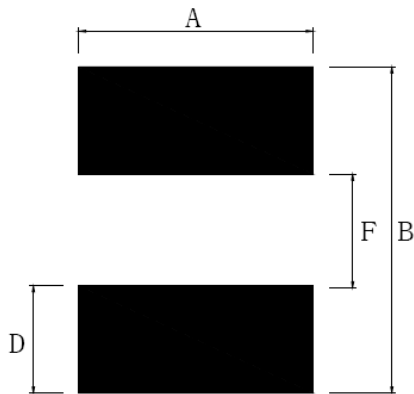


Package Dimensions-0201 Flip chip



Symbol	0201 Filpchip					
	Millimeters			Inches		
	Min	Typ	Max	Min	Typ	Max
A	0.595	0.620	0.645	0.023	0.024	0.025
B	0.295	0.320	0.345	0.011	0.012	0.013
C	0.245	0.275	0.301	0.009	0.010	0.12
D	0.145	0.150	0.155	0.005	0.006	0.006
E	0.245	0.250	0.255	0.009	0.009	0.010
F	0.245	0.250	0.255	0.009	0.009	0.010
G	0.005	0.010	0.015	0.0002	0.0004	0.0006

Pad Design



Pad Design		
Symbol	Millimeters	Inches
A	0.60	0.024
B	1.00	0.039
D	0.35	0.014
F	0.30	0.012

Part Marking System and Ordering information

	Package	Marking	Min.Order Qty. (PCS)
	0201 Flipchip	-	10,000